



JMSH0606AKQ

## 60V 4.4mΩ N-Ch Power MOSFET

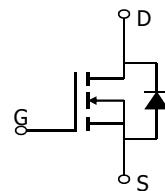
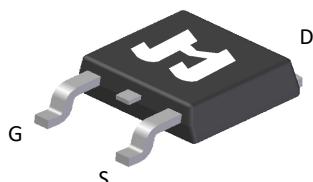
## Features

- Ultra-low  $R_{DS(ON)}$
- Low Gate Charge
- 100% UIS Tested, 100%  $R_g$  Tested
- Pb-free Lead Plating
- Halogen-free and RoHS-compliant
- AEC-Q101 Qualified for Automotive Applications

## Product Summary

Parameter	Value	Unit
$V_{DS}$	60	V
$V_{GS(th)}_{Typ}$	2.8	V
$I_D (@ V_{GS} = 10V)^{(1)}$	95	A
$R_{DS(ON)}_{Typ} (@ V_{GS} = 10V)$	4.4	mΩ

TO-252-3L Top View

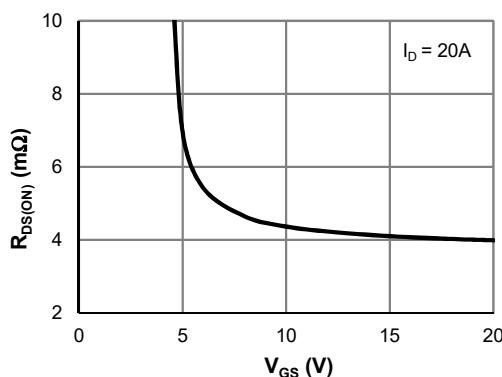


## Ordering Information

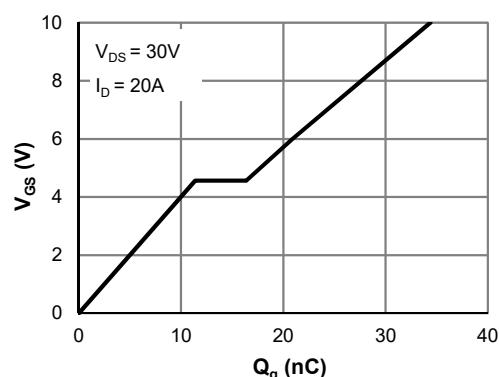
Device	Package	# of Pins	Marking	MSL	$T_J$ (°C)	Media	Quantity (pcs)
JMSH0606AKQ-13	TO-252-3L	3	SH0606AQ	1	-55 to 175	13-inch Reel	2500

Absolute Maximum Ratings (@  $T_A = 25^\circ\text{C}$  unless otherwise specified)

Parameter	Symbol	Value	Unit
Drain-to-Source Voltage	$V_{DS}$	60	V
Gate-to-Source Voltage	$V_{GS}$	$\pm 20$	V
Continuous Drain Current <small>(1)</small>	$I_D$	95	A
$T_C = 100^\circ\text{C}$		67	
Pulsed Drain Current <small>(2)</small>	$I_{DM}$	263	A
Avalanche Energy <small>(3)</small>	$E_{AS}$	216	mJ
Power Dissipation <small>(4)</small>	$P_D$	100	W
$T_C = 100^\circ\text{C}$		50	
Junction & Storage Temperature Range	$T_J, T_{STG}$	-55 to 175	°C

 $R_{DS(ON)}$  vs.  $V_{GS}$ 

Gate Charge



**Electrical Characteristics (@  $T_J = 25^\circ\text{C}$  unless otherwise specified)**

Parameter	Symbol	Conditions	Min.	Typ.	Max.	Unit
<b>STATIC PARAMETERS</b>						
Drain-Source Breakdown Voltage	$V_{(\text{BR})\text{DSS}}$	$I_D = 250\mu\text{A}, V_{GS} = 0\text{V}$	60			V
Zero Gate Voltage Drain Current	$I_{\text{DSS}}$	$V_{DS} = 48\text{V}, V_{GS} = 0\text{V}$ $T_J = 55^\circ\text{C}$			1.0	$\mu\text{A}$
					5.0	
Gate-Body Leakage Current	$I_{GSS}$	$V_{DS} = 0\text{V}, V_{GS} = \pm 20\text{V}$			$\pm 100$	nA
Gate Threshold Voltage	$V_{GS(\text{th})}$	$V_{DS} = V_{GS}, I_D = 250\mu\text{A}$	2.2	2.8	3.4	V
Static Drain-Source ON-Resistance	$R_{DS(\text{ON})}$	$V_{GS} = 10\text{V}, I_D = 20\text{A}$		4.4	5.5	$\text{m}\Omega$
Forward Transconductance	$g_{FS}$	$V_{DS} = 5\text{V}, I_D = 20\text{A}$		80		S
Diode Forward Voltage	$V_{SD}$	$I_S = 1\text{A}, V_{GS} = 0\text{V}$		0.70	1.0	V
Diode Continuous Current	$I_S$	$T_C = 25^\circ\text{C}$			95	A
<b>DYNAMIC PARAMETERS<sup>(5)</sup></b>						
Input Capacitance	$C_{iss}$	$V_{GS} = 0\text{V}, V_{DS} = 30\text{V}, f = 1\text{MHz}$		1492		pF
Output Capacitance	$C_{oss}$			940		pF
Reverse Transfer Capacitance	$C_{rss}$			109		pF
Gate Resistance	$R_g$	$V_{GS} = 0\text{V}, V_{DS} = 0\text{V}, f = 1\text{MHz}$		2.2		$\Omega$
<b>SWITCHING PARAMETERS<sup>(5)</sup></b>						
Total Gate Charge (@ $V_{GS} = 10\text{V}$ )	$Q_g$	$V_{GS} = 0 \text{ to } 10\text{V}$ $V_{DS} = 30\text{V}, I_D = 20\text{A}$		34		nC
Total Gate Charge (@ $V_{GS} = 6.0\text{V}$ )	$Q_g$			21		nC
Gate Source Charge	$Q_{gs}$			11.4		nC
Gate Drain Charge	$Q_{gd}$			5.0		nC
Turn-On DelayTime	$t_{D(\text{on})}$	$V_{GS} = 10\text{V}, V_{DS} = 30\text{V}$ $R_L = 1.5\Omega, R_{\text{GEN}} = 3\Omega$		12.6		ns
Turn-On Rise Time	$t_r$			27		ns
Turn-Off DelayTime	$t_{D(\text{off})}$			28		ns
Turn-Off Fall Time	$t_f$			8.0		ns
Body Diode Reverse Recovery Time	$t_{rr}$	$I_F = 20\text{A}, dI_F/dt = 100\text{A}/\mu\text{s}$		35		ns
Body Diode Reverse Recovery Charge	$Q_{rr}$	$I_F = 20\text{A}, dI_F/dt = 100\text{A}/\mu\text{s}$		25		nC

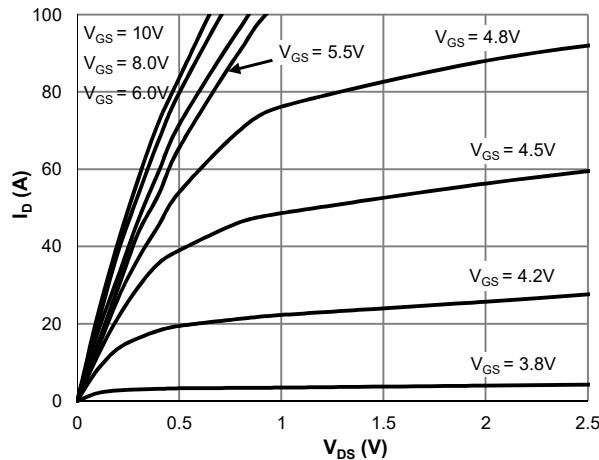
**Thermal Performance**

Parameter	Symbol	Typ.	Max.	Unit
Thermal Resistance, Junction-to-Ambient	$R_{\theta JA}$	42	50	$^\circ\text{C/W}$
Thermal Resistance, Junction-to-Case	$R_{\theta JC}$	1.5	1.8	$^\circ\text{C/W}$

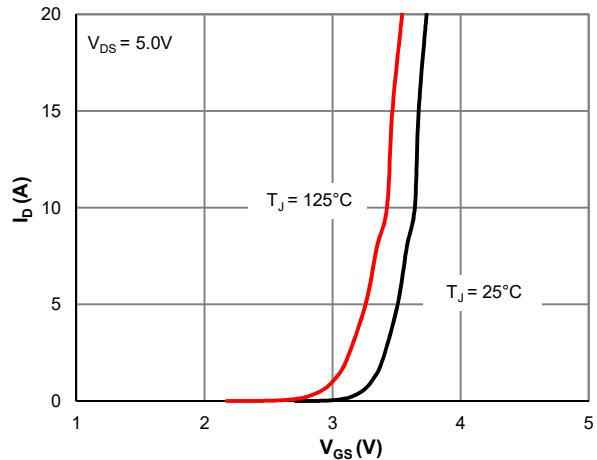
**Notes:**

1. Computed continuous current assumes the condition of  $T_{J_{\text{Max}}}$  while the actual continuous current depends on the thermal & electro-mechanical application board design.
2. This single-pulse measurement was taken under  $T_{J_{\text{Max}}} = 175^\circ\text{C}$ .
3.  $E_{AS}$  of 216 mJ is based on starting  $T_J = 25^\circ\text{C}, L = 3.0\text{mH}, I_{AS} = 12\text{A}, V_{GS} = 10\text{V}, V_{DD} = 30\text{V}$ ; 100% test at  $L = 0.3\text{mH}, I_{AS} = 25\text{A}$ .  
 $T_{J_{\text{Max}}} = 175^\circ\text{C}$ .
4. The power dissipation  $P_D$  is based on  $T_{J_{\text{Max}}} = 175^\circ\text{C}$ .
5. This value is guaranteed by design hence it is not included in the production test.

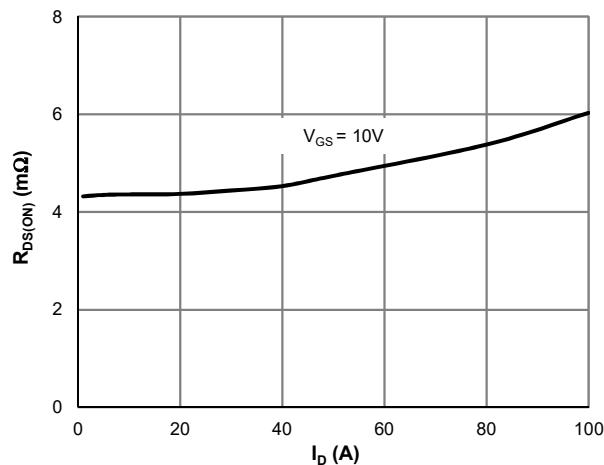
### Typical Electrical & Thermal Characteristics



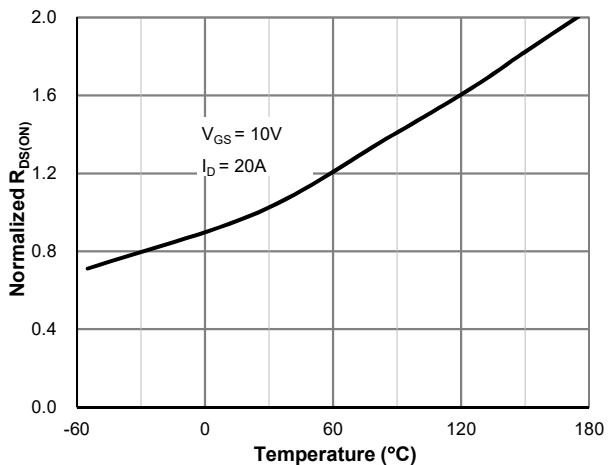
**Figure 1: Saturation Characteristics**



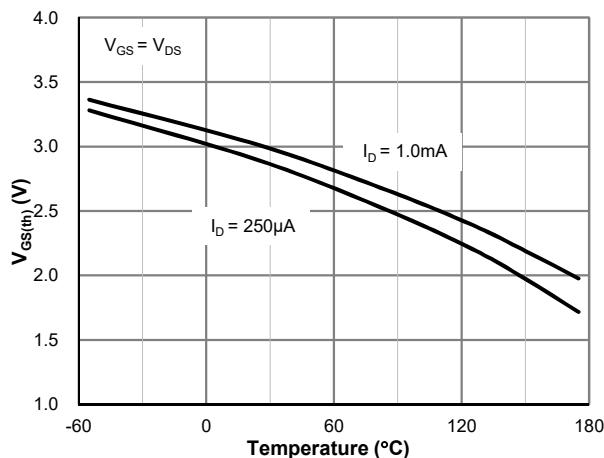
**Figure 2: Transfer Characteristics**



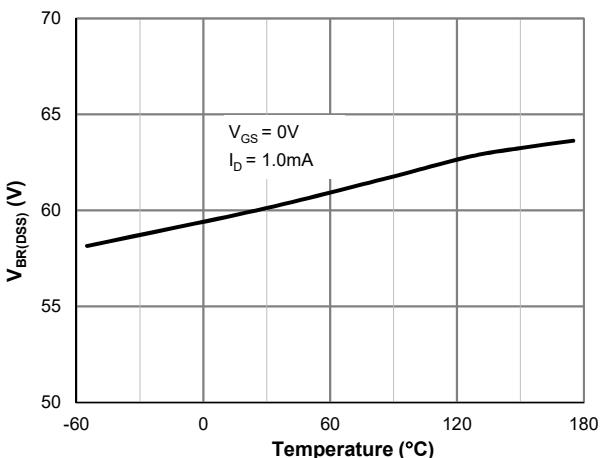
**Figure 3:  $R_{DS(ON)}$  vs. Drain Current**



**Figure 4:  $R_{DS(ON)}$  vs. Junction Temperature**

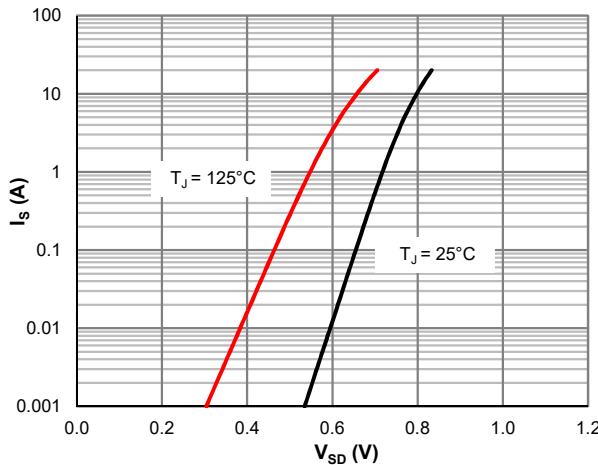


**Figure 5:  $V_{GS(th)}$  vs. Junction Temperature**

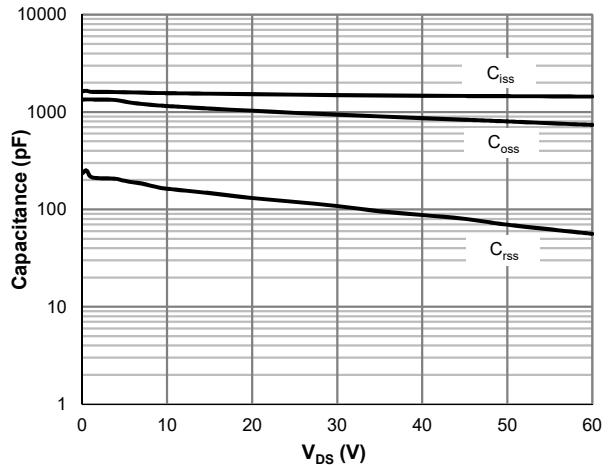


**Figure 6:  $V_{BR(DSS)}$  vs. Junction Temperature**

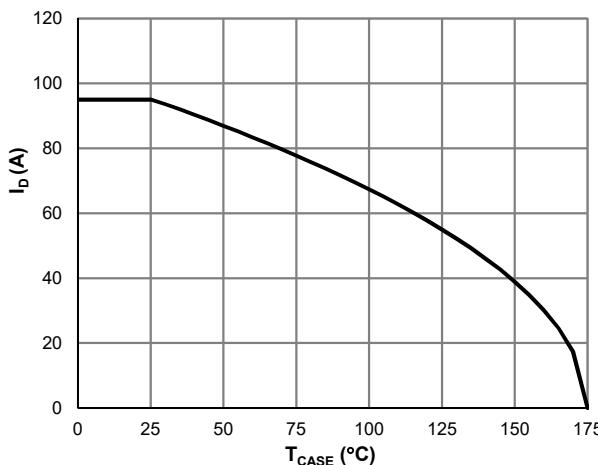
### Typical Electrical & Thermal Characteristics



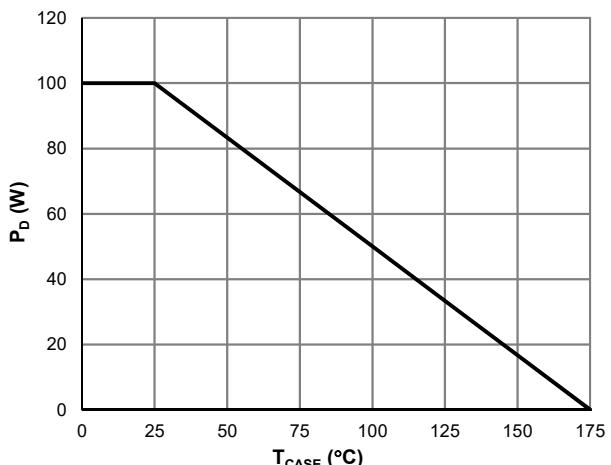
**Figure 7: Body-Diode Characteristics**



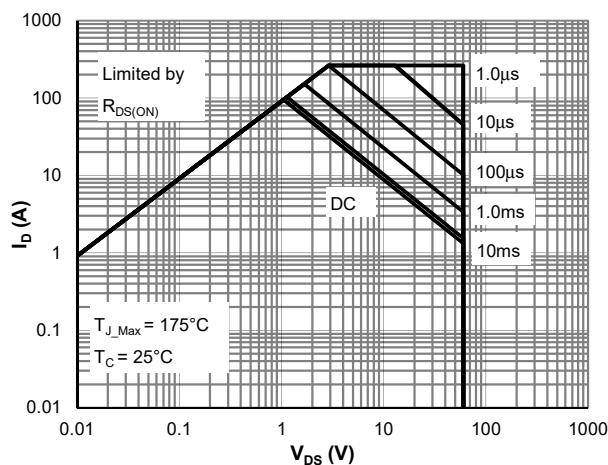
**Figure 8: Capacitance Characteristics**



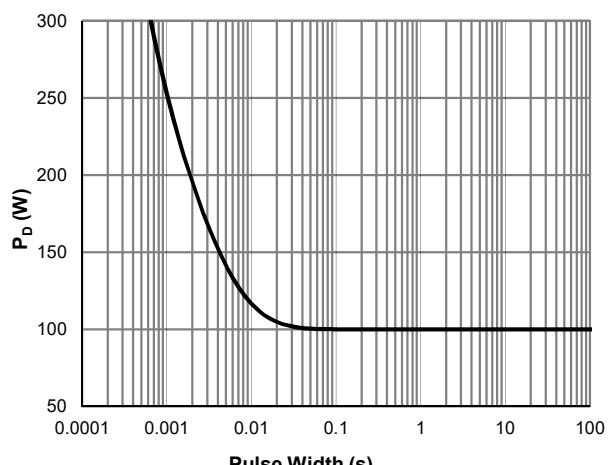
**Figure 9: Current De-rating**



**Figure 10: Power De-rating**



**Figure 11: Maximum Safe Operating Area**



**Figure 12: Single Pulse Power Rating, Junction-to-Case**

### Typical Electrical & Thermal Characteristics

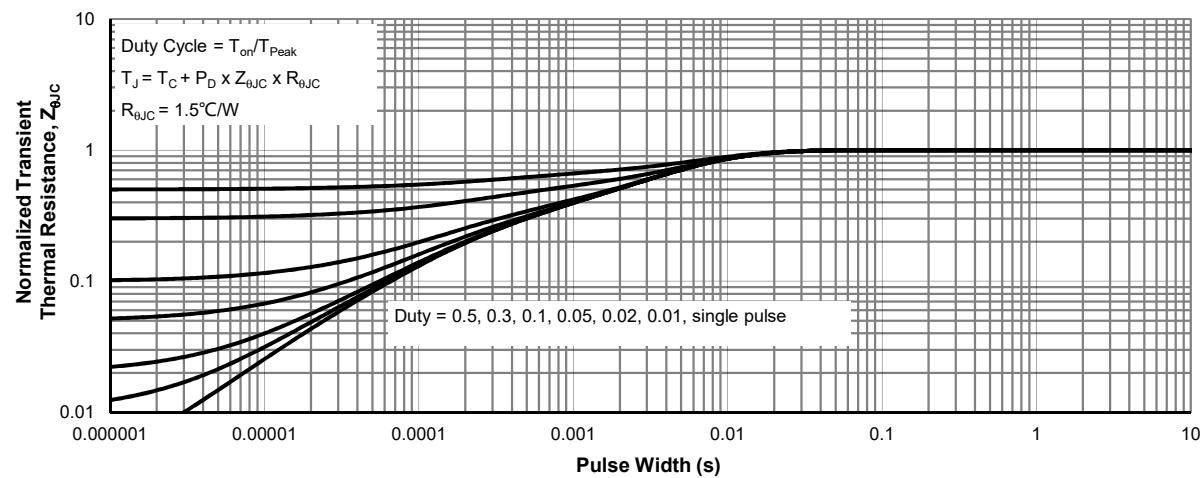
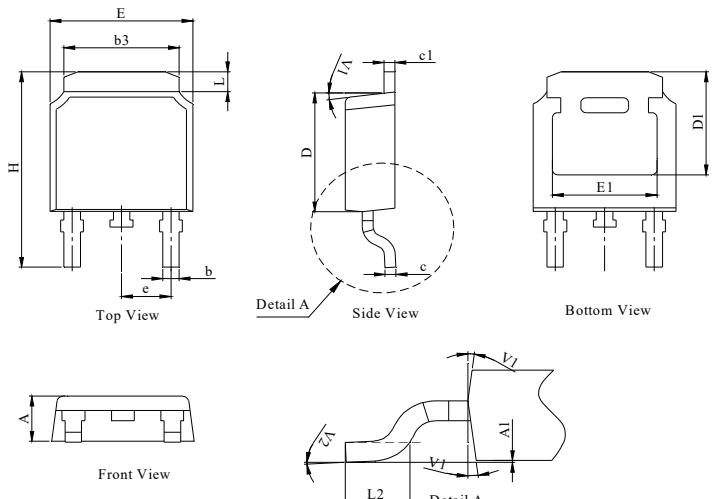


Figure 13: Normalized Maximum Transient Thermal Impedance

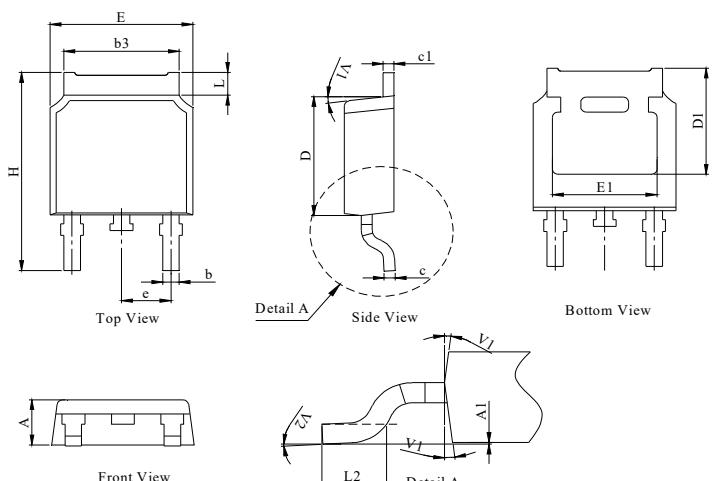
### TO-252-3L Package Information

#### Package Outline Type-A



DIM.	MILLIMETER		
	MIN.	NOM.	MAX.
A	2.18	2.30	2.39
A1	0	--	0.13
b	0.64	0.76	0.89
c	0.40	0.50	0.61
c1	0.46	0.50	0.58
D	5.97	6.10	6.23
D1	5.05	--	--
E	6.35	6.60	6.73
E1	4.32	--	--
b3	5.21	5.38	5.55
e	2.29 BSC		
H	9.40	10.00	10.40
L	0.89	--	1.27
L2	1.40	--	1.78
V1	7° REF		
V2	0°	--	6°

#### Package Outline Type-B



DIM.	MILLIMETER		
	MIN.	NOM.	MAX.
A	2.10	2.30	2.40
A1	0	--	0.13
b	0.66	0.76	0.86
b3	5.21	5.38	5.55
c	0.40	0.50	0.60
c1	0.44	0.50	0.58
D	5.90	6.10	6.30
D1	5.30REF		
E	6.40	6.60	6.80
E1	4.63	-	-
e	2.29 BSC		
H	9.50	10.00	10.70
L	1.09	--	1.21
L2	1.35	--	1.65
V1	7° REF		
V2	0°	--	6°

#### Recommended Soldering Footprint

